> Multiline TRL Calibration

Pitch: $25 \mu m$, **Frequency:** WR-1.0 - WR-5.1, **Configuration:** Ground-Signal-Ground

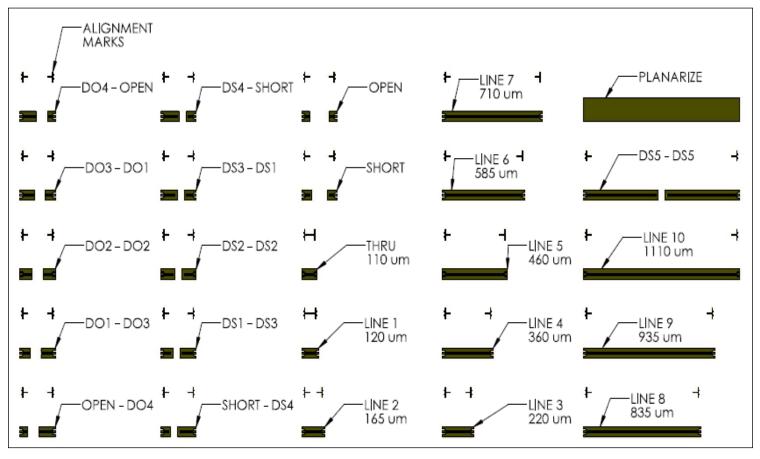
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Calibration Sites: 12 Site Spacing: $6000 \mu m \times 2650 \mu m$

West Probe Fixed Index Step: 1000 μm x 500 μm, Alignment Mark Offset: 250 μm Step North



Note: Line lengths are specified as conductor edge-to-edge dimension.

SPECIFICATIONS

Substrate Material: High-resistivity Silicon, Substrate Thickness: 275 μm Dielectric Constant: 11.8, Nominal Line Z_o : 50 Ohm

OVERTRAVEL AND ALIGNMENT

Prior to contacting the calibration standards, alignment and overtravel should be set using the alignment marks. On initial contact, the leading edge of the probe contacts should be aligned with the outmost edge "A" of the alignment mark, shown in Figure 1. To reach final contact, overtravel should be increased until the leading edge of the probe contacts is aligned with the innermost edge "B" of the alignment mark, shown in Figure 2.

Note: Calibration substrate must be mounted on an absorber material (such as ISS Holder P/N 116-344).



Figure 1: Initial contact



Figure 2: Final contact

> Recommended Line Configurations

- 1	Band	WR-1.0 (750 - 1100 GHz)	WR-2.2 (325 - 500 GHz)	WR-3.4 (220 - 330 GHz)	WR-4.3 (170 - 260 GHz)	WR-5.1 (140 - 220 GHz)	
I	Lines	Thru	Thru	Thru	Thru	Thru	
		Line 1	Line 2	Line 3	Line 3	Line 3	
		Line 2	Line 4	Line 5	Line 6	Line 7	
I	Lines	Line 1	Line 2	Line 3	Line 3	Line 3	

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